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INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICANT Delhougne, et al.	
(USE SEVERAL SHEETS IF NECESSARY)	FILING DATE January 13, 2004	GROUP ~~Unknown~~ 2800

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)
NN	1	6190975	2/2/01	Kubo, et al.			—
NN	2	2001-028067 A1	10/11/01	Awano, Y.			—

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	TRANSLATION NO
NN	3	0215244	2/21/02	PCT				✓
NN	4	0201624	1/3/02	PCT				✓

EXAMINER INITIAL		OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)
NN	5	European Search Report dated October 23, 2003 in Equivalent European Application No. 03 44 7007.
NN	6	Osten, et al., Appl. Phys. Lett., Vol. 70, No. 21, pp 2813-2815 (May 26, 1997).
NN	7	Lanzerotti, et al., Electron Devices Meeting, San Francisco, Dec. 8-11 1996, pages 249-252, IEEE (December 8, 1996)
NN	8	Osten, et al., Appl. Phys. Lett., Vol. 64, No. 25, pp 3440-3442 (June 20, 1994).
NN	9	G. A. Shafeev and P. Hoffmann, Appl. Surf. Sci. 138-139: 455-460 (1999).

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EXAMINER NN	DATE CONSIDERED 2-18-05

*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.